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Application/Control No.	Applicant(s)/Patent under Reexamination
10/725,931	MATSUMI ET AL.
Examiner	Art Unit
HUNG Q. DANG	2621

SEARCHED				
Class	Subclass	Date	Examiner	
386	55, 86, 95, 111	3/3/2008	HQD	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventors' Names Search	6/26/2007	НQD		
USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	6/25/2007- 6/26/2007, 3/3/2008	HQD		
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